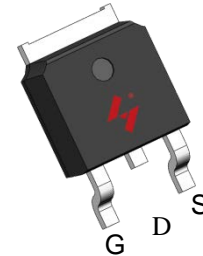


Single N-Channel Enhancement Mode MOSFET

Feature

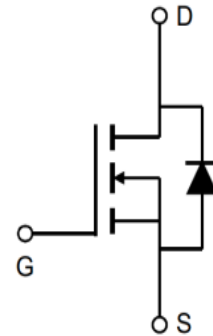
- 60V/67A
- $R_{DS(ON)} = 5.5 \text{ m}\Omega(\text{typ.}) @ V_{GS} = 10\text{V}$
- $R_{DS(ON)} = 7.6 \text{ m}\Omega(\text{typ.}) @ V_{GS} = 4.5\text{V}$
- 100% Avalanche Tested
- Reliable and Rugged
- Halogen- Free Devices Available

Pin Description




Applications

- Power Management for DC/DC
- Switching Application



Single N-Channel MOSFET

Ordering and Marking Information

 D G052N06 XYMXXXXXX	Package Code D: TO-252-2L Date Code XYMXXXXXX
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Note: HUAYI lead-free products contain molding compounds/die attach materials and 100% matte tin plate Termination finish; which are fully compliant with RoHS. HUAYI lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J-STD-020 for MSL classification at lead-free peak reflow temperature. HUAYI defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this product and/or to this document at any time without notice.

Absolute Maximum Ratings

Symbol	Parameter		Rating	Unit
Common Ratings (Tc=25 Unless Otherwise Noted)				
V _{DSS}	Drain-Source Voltage		60	V
V _{GSS}	Gate-Source Voltage		20	V
T _J	Junction Temperature Range		-55 to 175	
T _{STG}	Storage Temperature Range		-55 to 175	
I _S	Source Current-Continuous(Body Diode)	Tc=25	67	A
Mounted on Large Heat Sink				
I _{DM}	Pulsed Drain Current *	Tc=25	268	A
I _D	Continuous Drain Current	Tc=25	67	A
		Tc=100	47	A
P _D	Maximum Power Dissipation	Tc=25	60	W
		Tc=100	30	W
R _{θJC}	Thermal Resistance, Junction-to-Case		2.5	W
R _{θJA}	Thermal Resistance, Junction-to-Ambient **		110	W
E _{AS}	SinglePulsed-Avalanche Energy ***	L=0.3mH	169.8	mJ

Note: * Repetitive rating pulse width limited by max.junction temperature.

** Surface mounted on FR-4 board.

*** Limited by T_{Jmax}, starting T_J=25, L=0.3mH, R_G=25, V_{GS}=10V.

Electrical Characteristics(Tc =25 Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	HYG052N06LS1			Unit
			Min	Typ.	Max	
Static Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250μA	60	-	-	V
I _{DSS}	Drain-to-Source Leakage Current	V _{DS} =60V, V _{GS} =0V	-	-	1	μA
		T _J =125	-	-	50	μA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250μA	1	1.7	3	V
I _{GSS}	Gate-Source Leakage Current	V _{GS} = 20V, V _{DS} =0V	-	-	100	nA
R _{DS(ON)}	Drain-Source On-State Resistance	V _{GS} =10V, I _{DS} =30A	-	5.5	6.6	m
		V _{GS} =4.5V, I _{DS} =20A	-	7.6	9.1	m
Diode Characteristics						
V _{SD} *	Diode Forward Voltage	I _{SD} =30A, V _{GS} =0V	-	0.88	1.2	V
t _{rr}	Reverse Recovery Time	I _{SD} =30A, dI _{SD} /dt=100A/μs	-	27	-	ns
Q _{rr}	Reverse Recovery Charge		-	14.7	-	nC

Electrical Characteristics (Cont.) (Tc =25 Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	HYG052N06LS1			Unit
			Min	Typ.	Max	
Dynamic Characteristics						
R _G	Gate Resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz	-	2.2	-	
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =25V, Frequency=1.0MHz	-	1638	-	pF
C _{oss}	Output Capacitance		-	755	-	
C _{rss}	Reverse Transfer Capacitance		-	16	-	
t _{d(ON)}	Turn-on Delay Time	V _{DD} =30V, R _G =4Ω, I _{DS} =30A, V _{GS} =10V	-	8.4	-	ns
T _r	Turn-on Rise Time		-	42.5	-	
t _{d(OFF)}	Turn-off Delay Time		-	24.6	-	
T _f	Turn-off Fall Time		-	55.9	-	
Gate Charge Characteristics						
Q _g	Total Gate Charge V _{GS} =10V	V _{DS} =48V, I _D =30A	-	28.7	-	nC
Q _g	Total Gate Charge V _{GS} =4.5V)		-	13.7	-	
Q _{gs}	Gate-Source Charge		-	6.4	-	
Q _{gd}	Gate-Drain Charge		-	5.0	-	

Note: *Pulse test pulse width ≤ 300us duty cycle ≤ 2%

Typical Operating Characteristics

Figure 1: Power Dissipation

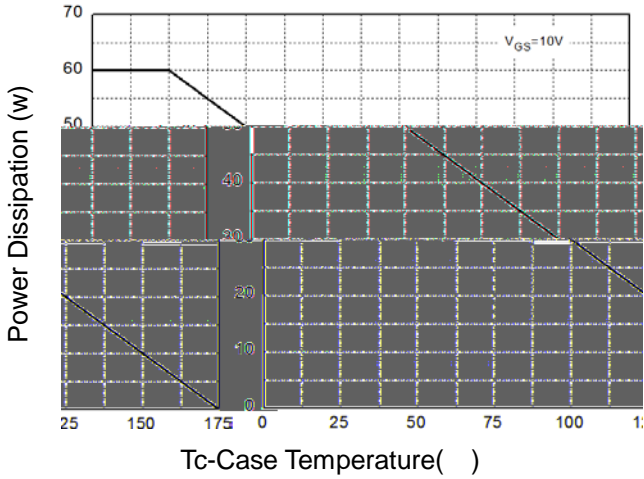


Figure 2: Drain Current

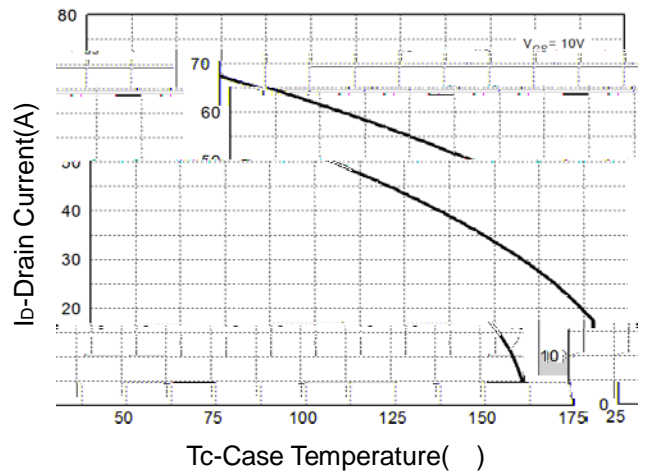


Figure 3: Safe Operation Area

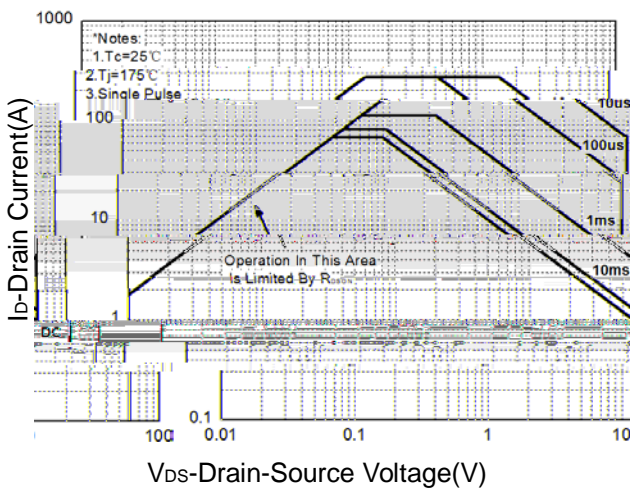


Figure 4: Thermal Transient Impedance

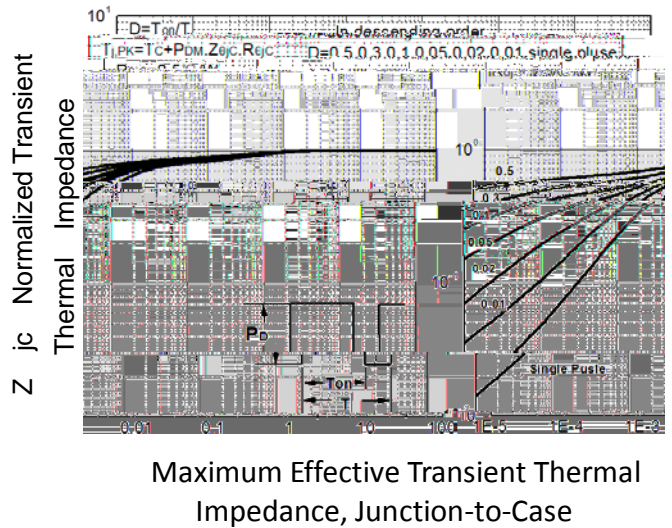


Figure 5: Output Characteristics

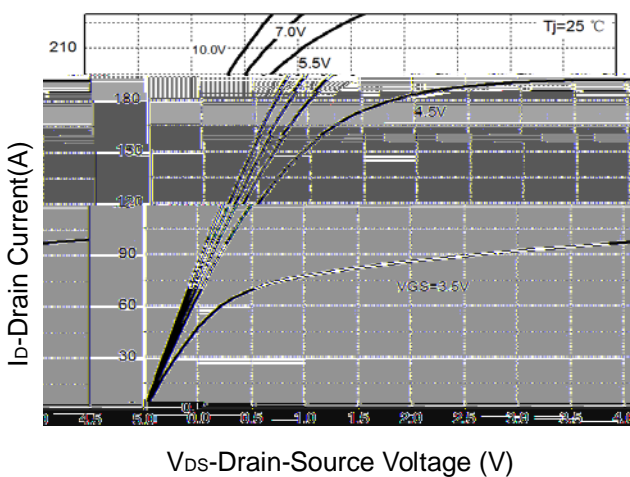
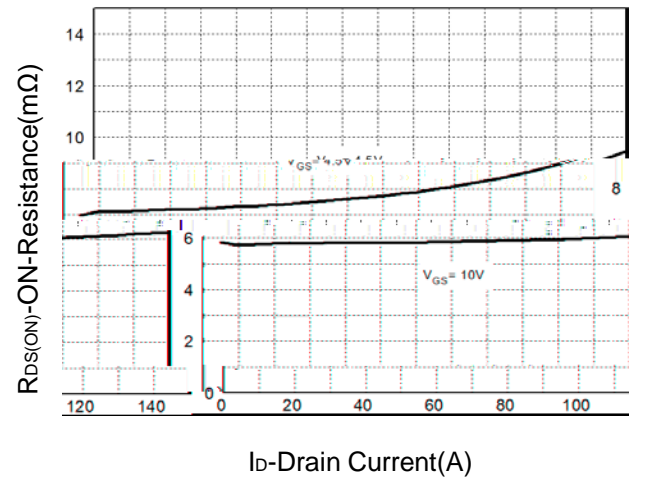
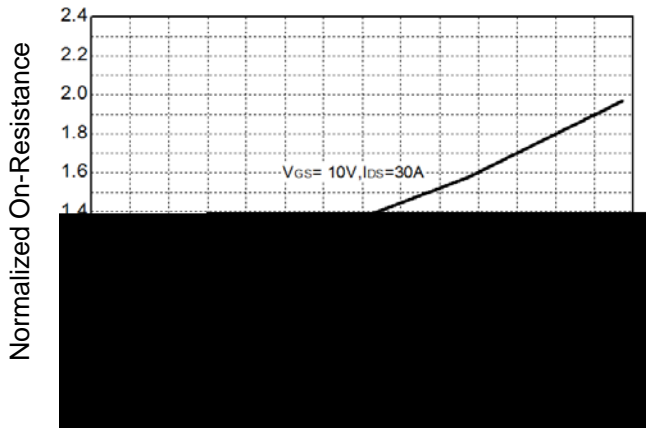


Figure 6: Drain-Source On Resistance



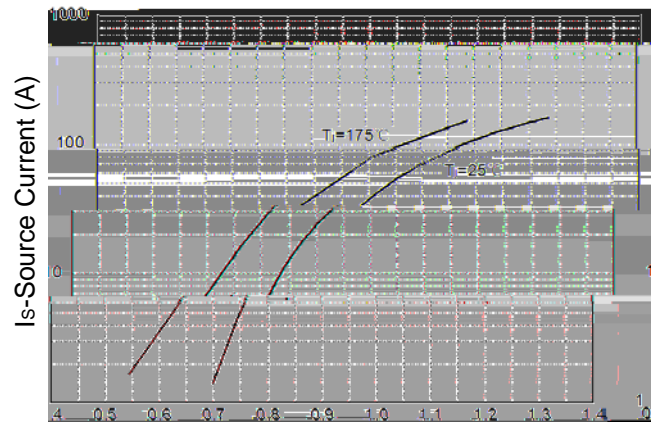
Typical Operating Characteristics(Cont.)

Figure 7: On-Resistance vs. Temperature



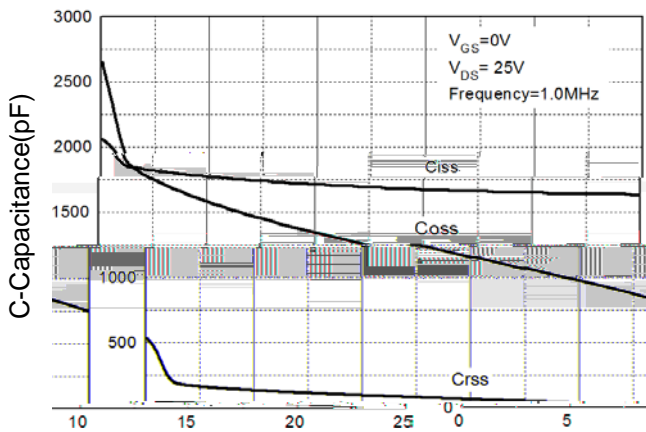
T_j-Junction Temperature (°C)

Figure 8: Source-Drain Diode Forward



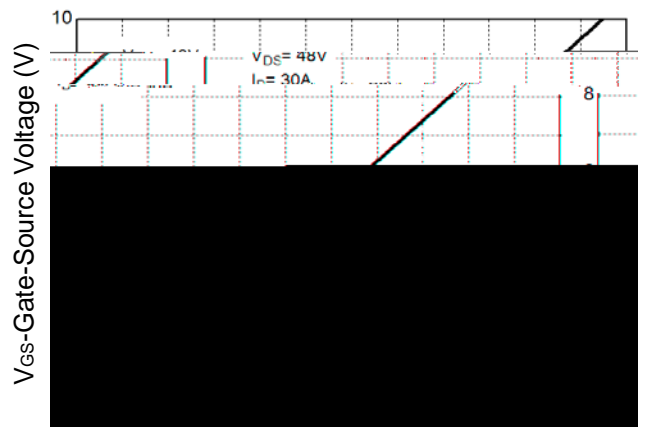
V_{SD}-Source-Drain Voltage(V)

Figure 9: Capacitance Characteristics



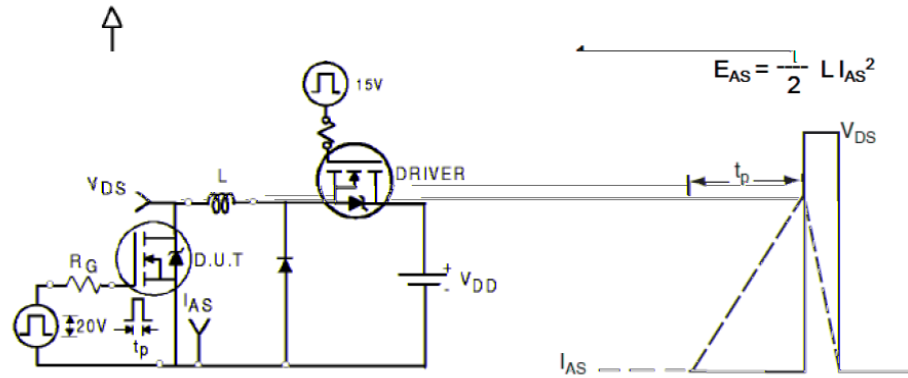
V_{DS}-Drain-Source Voltage (V)

Figure 10: Gate Charge Characteristics

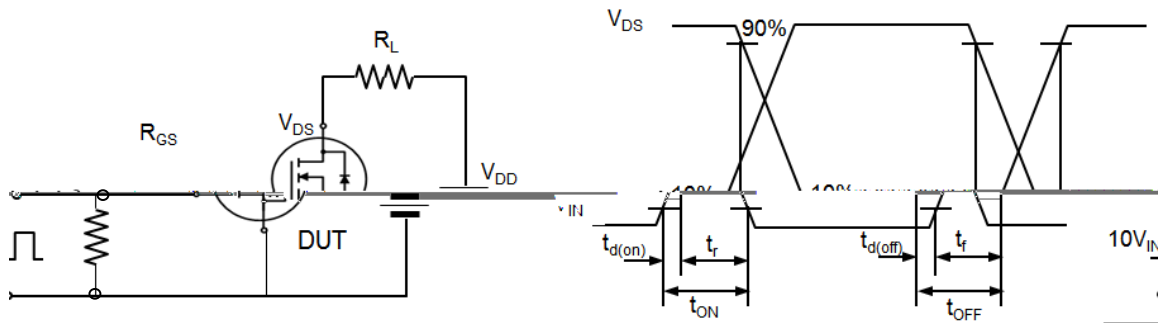


Q_G-Gate Charge (nC)

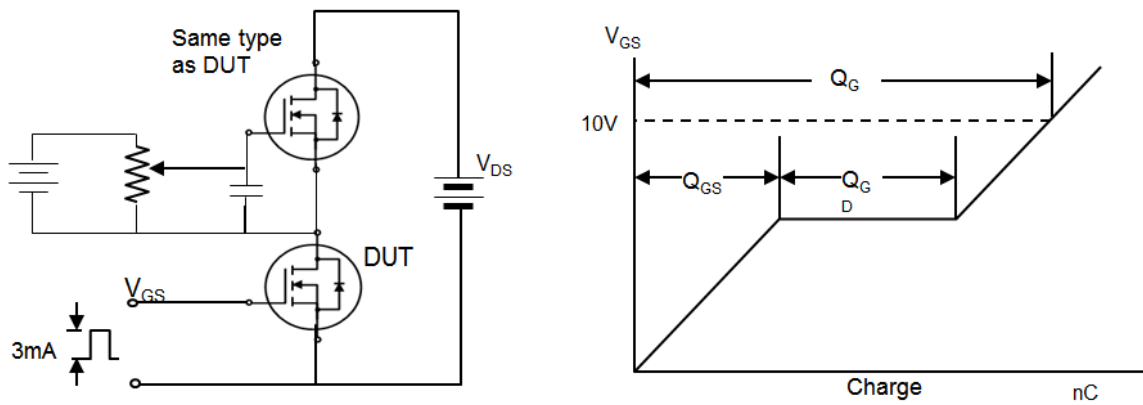
Avalanche Test Circuit



Switching Time Test Circuit



Gate Charge Test Circuit

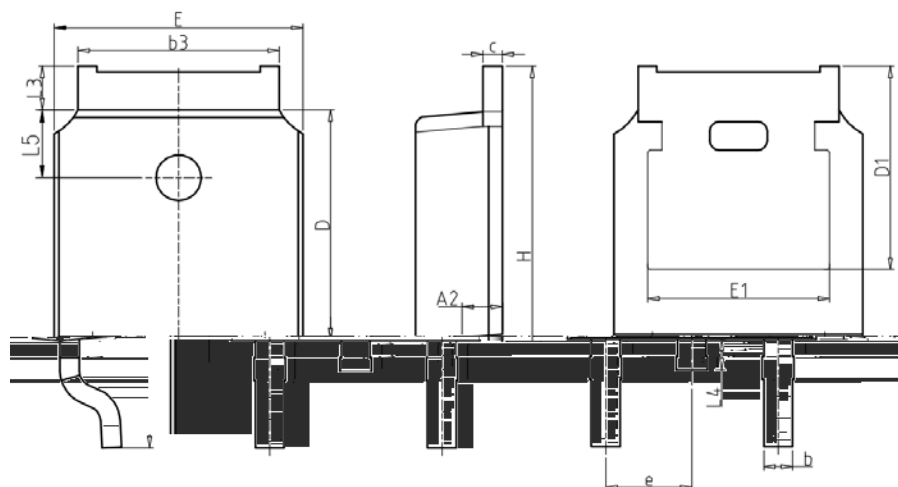


Device Per Unit

Package Type	Unit	Quantity
TO-252-2L	Tube	75
TO-252-2L	Reel	2500

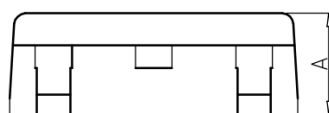
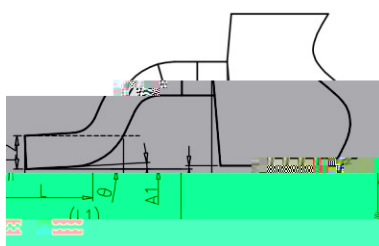
Package Information

TO-252-2L

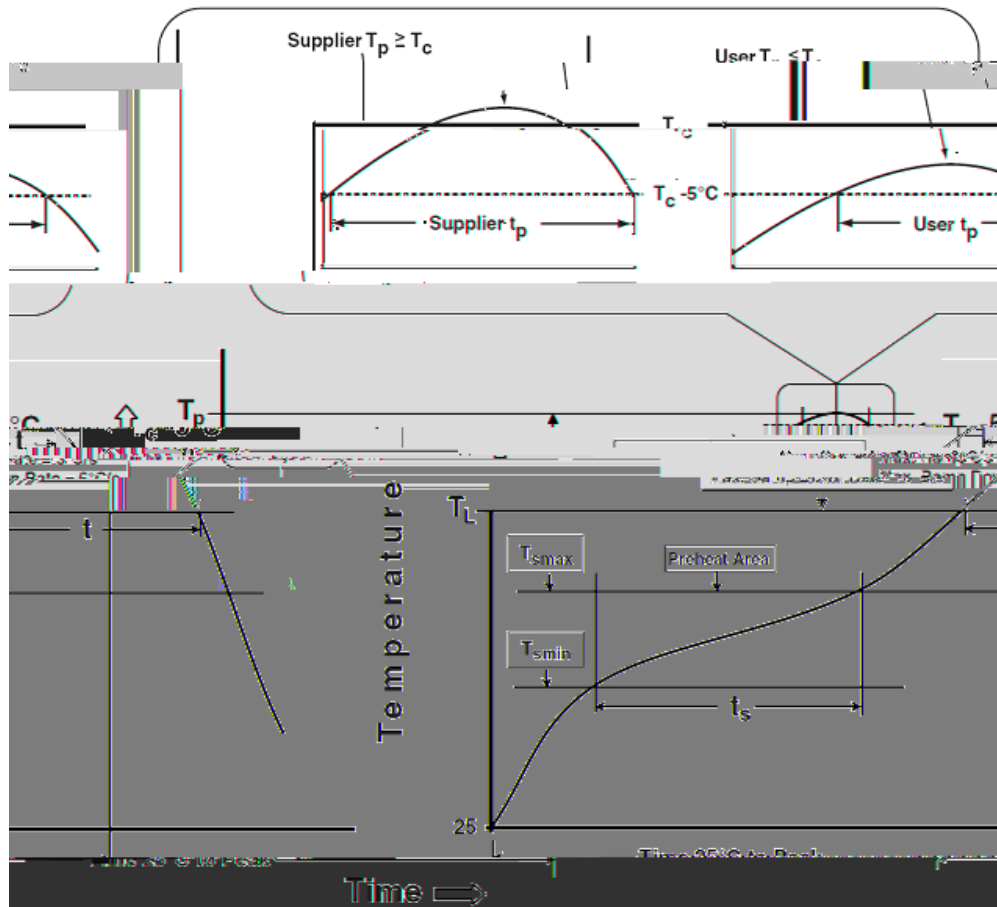


COMMON DIMENSIONS

SYMBOL	mm		
	MIN	NOM	MAX
A	2.20	2.30	2.40
A1	0.00	-	0.20
A2	0.97	1.07	1.17
b	0.68	0.78	0.90
b3	5.20	5.33	5.50
c	0.43	0.53	0.63
D	5.98	6.10	6.22
D1	5.30REF		
E	6.40	6.60	6.80
E1	4.63	-	-
e	2.286BSC		
H	9.40	10.10	10.50
L	1.38	1.50	1.75
L1	2.90REF		
L2	0.51BSC		
L3	0.88	-	1.28
L4	-	-	1.00
L5	1.65	1.80	1.95
θ	0°	-	8°



Classification Profile



Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Preheat & Soak		
Temperature min (T_{smin})	100	150
Temperature max (T_{smax})	150	200
Time (T_{smin} to T_{smax}) (t_s)	60-120 seconds	60-120 seconds
Average ramp-up rate (T_{smax} to T_p)	3 /second max.	3 /second max.
Liquidous temperature (T_L)	183	217
Time at liquidous (t_l)	60-150 seconds	60-150 seconds
Peak package body Temperature (T_p)*	See Classification Temp in table 1	See Classification Temp in table 2
Time (t_p)** within 5 of the specified classification temperature (T_c)	20** seconds	30** seconds
Average ramp-down rate (T_p to T_{smax})	6 /second max.	6 /second max.
Time 25 to peak temperature	6 minutes max.	8 minutes max.

*Tolerance for peak profile Temperature (T_p) is defined as a supplier minimum and a user maximum.

** Tolerance for time at peak profile temperature (t_p) is defined as a supplier minimum and a user maximum.

Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

Package Thickness	Volume mm <350	Volume mm 350
2.5 mm	235	220
≥2.5 mm	220	220

Table 2.Pb-free Process – Classification Temperatures (Tc)

Package Thickness	Volume mm <350	Volume mm 350-2000	Volume mm 2000
<1.6 mm	260	260	260
1.6 mm – 2.5 mm	260	250	245
2.5 mm	250	245	245

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245
HTRB	JESD-22, A108	168 Hrs /500 Hrs /1000 Hrs, Bias @ 150
PCT	JESD-22, A102	96 Hrs, 100%RH, 2atm, 121
TCT	JESD-22, A104	500 Cycles, -55 ~150

Customer Service

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